## Notice of References Cited Application/Control No. 10/827,351 Examiner Hien N. Nguyen U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination NAGATA ET AL. Art Unit Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α.	US-6,574,757	06-2003	Park et al.	714/710
	В	US-2004/0208070	10-2004	Nagata et al.	365/201
	С	US-2005/0007841	01-2005	Nagata et al.	365/200
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	x						

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